

Notice of References Cited	Application/Control No. 10/623,645	Applicant(s)/Patent Under Reexamination WANG ET AL.	
	Examiner PETER L. CHENG	Art Unit 2625	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0163490 A1	11-2002	Nose, Takashi	345/89
*	B	US-2003/0132907 A1	07-2003	Lee et al.	345/98
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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